

<b>Notice of References Cited</b>	Application/Control No. 10/733,295	Applicant(s)/Patent Under Reexamination OHNISHI, SHINJI	
	Examiner LIN LIU	Art Unit 2445	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0111138	08-2002	Park, Seok-Hyo	455/41
	B	US-			
	C	US-			
	D	US-			
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